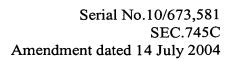
AMENDMENT TRANSMITTAL LETTER (Large Entity) Applicant(s): Ji-Soo KIM et al.						Docket No. SEC.745C	
Application No.	1			Customer No.		Group Art Uni 2881	Confirmation No.
MANUFACTURIN		ING DEGREE OF CHA R DEVICE AND APPAI				PLASMA US	ED FOR
4 TO A DEMI		COMMISSIONER FO n the above-identified apmitted as shown below.	pplication	— _			
		CLAIMS AS AM	ENDED			,	
	CLAIMS REMAINING AFTER AMENDMENT	HIGHEST # PREV. PAID FOR		MBER EXTRA		RATE	ADDITIONAL
TOTAL CLAIMS	9 -	20 =		0	Х	\$18.00	\$0.00
INDEP. CLAIMS	2 -	3 =		0	Х	\$86.00	\$0.00
Multiple Dependent Claims (check if applicable)							\$0.00
TOTAL ADDITIONAL FEE FOR THIS AMEND						MENT	\$0.00
☐ Please ch.☐ A check ir☐ The Directicommunic	ation or credit any ove additional filing fees re		the follow count No 1.16.	closed. ving fees as		ciated with this	5
KENNETH D. SP REG. NO.: 39,84 VOLENTINE FR 12200 SUNRISE V RESTON, VA 20 TEL. NO.: (703)	3 ANCOS, PLLC VALLEY DRIVE, SUI 191	ΓE 150	1 certify	that this nail under 3 sioner for Pa	doc 7 (ater	with the U.C.F.R. 1.8 and ats, P.O. Box	is being deposited on S. Postal Service as first is addressed to the 450, Alexandria, VA
cc:				_		erson Mailing Col	





IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re PATENT APPLICATION of:

Ji-Soo KIM et al.

Group Art Unit: 2881

Serial No.: 10/673,581

Examiner: Kalimah FERNANDEZ

Filed: 30 September 2003

METHOD OF DETERMINING
DEGREE OF CHARGE-UP
INDUCED BY PLASMA USED FOR
MANUFACTURING
SEMICONDUCTOR DEVICE AND
APPARATUS THEREFOR

AMENDMENT UNDER 37 C.F.R. § 1.112

U.S. Patent and Trademark Office 2011 South Clark Place Customer Window, Mail Stop <u>Amendment</u> Crystal Plaza Two, Lobby, Room 1B03 Arlington, VA 22202

Sir:

In response to the Office Action dated 10 May 2004, the period for response to which extends through 10 August 2004, please amend the above-identified patent application as follows:

Amendments to the Specification begin on page 2 of this paper.

Amendments to the Claims are reflected in the listing of claims which begins on page 3 of this paper.

Remarks begin on page 6 of this paper.